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SN74LV541A

SCLS410J-APRIL 1998-REVISED DECEMBER 2014

# SN74LV541A Octal Buffers/Drivers With 3-State Outputs

### 1 Features

- 2-V to 5.5-V V<sub>CC</sub> Operation
- Max t<sub>pd</sub> of 6 ns at 5 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
   < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot) > 2.3 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> =  $25^{\circ}$ C
- Support Mixed-Mode Voltage Operation on All Ports
- Ioff Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 3000-V Human-Body Model
  - 200-V Machine Model
  - 2000-V Charged-Device Model

## 2 Applications

- Smart Grids
- TVs
- Set-Top-Boxes
- Audio
- Servers
- Surveillance Cameras
- Network Switches
- Infotainment

### **3** Description

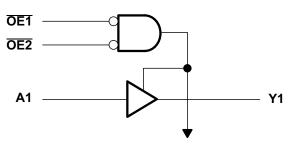
The SN74LV541A device is an octal buffer/driver designed for 2-V to 5.5-V  $V_{CC}$  operation.

#### Table 1. Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
	VQFN (20)	4.50 x 3.50 mm
	SSOP (20)	7.50 x 5.30 mm
SN74LV541A	TSSOP (20)	6.50 x 4.40 mm
	TVSOP (20)	5.00 x 4.40 mm
	SOIC (20)	12.80 x 7.50 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### 4 Simplified Schematic



**To Seven Other Channels** 

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## **Table of Contents**

9

1	reat	ures 1
2	Арр	lications 1
3	Des	cription 1
4	Sim	plified Schematic1
5		ision History2
6		Configuration and Functions
7	Spe	cifications 4
	7.1	Absolute Maximum Ratings 4
	7.2	ESD Ratings 4
	7.3	Recommended Operating Conditions 5
	7.4	Thermal Information 5
	7.5	Electrical Characteristics 6
	7.6	Switching Characteristics, $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V} \dots 6$
	7.7	Switching Characteristics, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V} \dots 6$
	7.8	Switching Characteristics, $V_{CC} = 5 V \pm 0.5 V$
	7.9	Noise Characteristics7
	7.10	Operating Characteristics7
	7.11	Typical Characteristics 7
8	Para	ameter Measurement Information

## 5 Revision History

•

2

Changes from Revision I (April 2005) to Revision J

Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and	
Mechanical, Packaging, and Orderable Information section.	. 1
Deleted Ordering Information table.	. 1
Changed MAX operating temperature to 125°C in Recommended Operating Conditions table.	. 5

- www.ti.com 9.1 9.2 9.3 10 Application and Implementation...... 10 10.1 Application Information..... 10 10.2 Typical Application ..... 10 11 Power Supply Recommendations ...... 11 12 Layout..... 12 12.1 Layout Guidelines ..... 12
- 12.2 Layout Example ..... 12 13 Device and Documentation Support ...... 12 13.1 Related Links ..... 12 13.2 Trademarks ...... 12 13.3 Electrostatic Discharge Caution ...... 12 13.4 Glossary..... 12 14 Mechanical, Packaging, and Orderable Information ..... 12

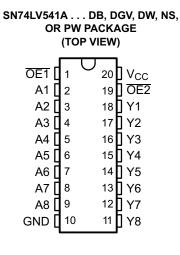
EXAS STRUMENTS

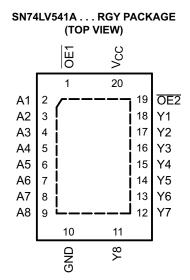
### Page



#### SN74LV541A SCLS410J – APRIL 1998 – REVISED DECEMBER 2014

## 6 Pin Configuration and Functions





#### **Pin Functions**

	PIN	TYPE	DESCRIPTION
NO.	NAME	TIPE	DESCRIPTION
1	OE1	I	Output Enable 1
2	A1	I	A1 Input
3	A2	I	A2 Input
4	A3	I	A3 Input
5	4A	I	A4 Input
6	A5	I	A5 Input
7	A6	I	A6 Input
8	A7	Ι	A7 Input
9	A8	I	A8 Input
10	GND	—	Ground Pin
11	Y8	0	Y8 Output
12	Y7	0	Y7 Output
13	Y6	0	Y6 Output
14	Y5	0	Y5 Output
15	Y4	0	Y4 Output
16	Y3	0	Y3 Output
17	Y2	0	Y2 Output
18	Y1	0	Y1 Output
19	OE2	I	Output Enable 2
20	V <sub>CC</sub>	_	Power Pin

### 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	7	V
VI	Input voltage range <sup>(2)</sup>		-0.5	7	V
Vo	Voltage range applied to any output in the high-impedance	-0.5	7	V	
Vo	Output voltage range applied in the high or low state $^{(2)(3)}$	-0.5	$V_{CC} + 0.5$	V	
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current	$V_{O} = 0$ to $V_{CC}$		±35	mA
	Continuous current through V <sub>CC</sub> or GND			±70	mA
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(3) This value is limited to 5.5-V maximum.

### 7.2 ESD Ratings

				VALUE	UNIT
			Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	3000	
V(	ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all $\ensuremath{pins^{(2)}}$	2000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.



### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			SN74LV54	1A	
			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	5.5	V
		$V_{CC} = 2 V$	1.5		
V		$V_{CC}$ = 2.3 V to 2.7 V	V <sub>CC</sub> × 0.7		V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 3 V to 3.6 V	V <sub>CC</sub> × 0.7		v
		$V_{CC}$ = 4.5 V to 5.5 V	V <sub>CC</sub> × 0.7		
		$V_{CC} = 2 V$		0.5	
V	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		$V_{CC} \times 0.3$	V
V <sub>IL</sub>	Low-level input voltage	$V_{CC}$ = 3 V to 3.6 V		$V_{CC} \times 0.3$	v
		$V_{CC}$ = 4.5 V to 5.5 V		$V_{CC} \times 0.3$	
VI	Input voltage		0	5.5	V
V	Output voltage	High or low state	0	V <sub>CC</sub>	V
Vo	Oulput voltage	3-state	0	5.5	v
		$V_{CC} = 2 V$		-50	μA
L	High-level output current	$V_{CC}$ = 2.3 V to 2.7 V		-2	
I <sub>OH</sub>	High-level output current	$V_{CC}$ = 3 V to 3.6 V		-8	mA
		$V_{CC}$ = 4.5 V to 5.5 V		-16	
		$V_{CC} = 2 V$		50	μA
	Low-level output current	$V_{CC}$ = 2.3 V to 2.7 V		2	
I <sub>OL</sub>	Low-level output current	$V_{CC}$ = 3 V to 3.6 V		8	mA
		$V_{CC}$ = 4.5 V to 5.5 V		16	
		$V_{CC}$ = 2.3 V to 2.7 V		200	
Δt/Δv	Input transition rise or fall rate	$V_{CC}$ = 3 V to 3.6 V		100	ns/V
		$V_{CC}$ = 4.5 V to 5.5 V		20	
T <sub>A</sub>	Operating free-air temperature		-40	125	°C

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs* (SCBA004).

### 7.4 Thermal Information

				SN74L	V541A			
	THERMAL METRIC <sup>(1)</sup>	DB	DGV	DW	NS	PW	RGY	UNIT
		20 PINS						
$R_{\theta JA}$	Junction-to-ambient thermal resistance	96.0	116.1	79.8	77.1	102.8	35.1	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	57.7	31.3	45.8	43.6	36.8	43.3	
$R_{\theta JB}$	Junction-to-board thermal resistance	51.2	57.6	47.4	44.6	53.8	12.9	
Ψյτ	Junction-to-top characterization parameter	19.4	1.0	18.5	17.2	2.5	0.9	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	50.8	56.9	47.0	44.2	53.3	12.9	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	_	_	_	_	_	7.9	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

SN74LV541A SCLS410J – APRIL 1998–REVISED DECEMBER 2014

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## 7.5 Electrical Characteristics

	TEST CONDITIONS	V	Τ,	λ = 25°C		–40°C to	85°C	–40°C to 125°C		UNIT
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	I <sub>OH</sub> = -50 μA	2 V to 5.5 V	V <sub>CC</sub> – 0.1			V <sub>CC</sub> – 0.1		V <sub>CC</sub> – 0.1		
V <sub>OH</sub>	$I_{OH} = -2 \text{ mA}$	2.3 V	2			2		2		V
	I <sub>OH</sub> = -8 mA	3 V	2.48			2.48		2.48		
	I <sub>OH</sub> = -16 mA	4.5 V	3.8			3.8		3.8		
	I <sub>OL</sub> = 50 μA	2 V to 5.5 V			0.1		0.1		0.1	
V <sub>OL</sub>	$I_{OL} = 2 \text{ mA}$	2.3 V			0.4		0.4		0.4	V
	$I_{OL} = 8 \text{ mA}$	3 V			0.44		0.44		0.44	
	I <sub>OL</sub> = 16 mA	4.5 V			0.55		0.55		0.55	
I <sub>I</sub>	$V_1 = 5.5 V \text{ or GND}$	0 to 5.5 V			±1		±1		±1	μA
I <sub>OZ</sub>	$V_{O} = V_{CC}$ or GND	5.5 V			±5		±5		±5	μA
I <sub>CC</sub>	$V_I = V_{CC} \text{ or } GND, \qquad I_O = 0$	5.5 V			20		20		20	μA
l <sub>off</sub>	$V_1 \text{ or } V_0 = 0 \text{ to } 5.5 \text{ V}$				5		5		5	μA
Ci	$V_I = V_{CC}$ or GND	3.3 V		2						pF

over recommended operating free-air temperature range (unless otherwise noted)

### 7.6 Switching Characteristics, $V_{cc}$ = 2.5 V ± 0.2 V

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM TO		LOAD	T <sub>A</sub> = 25°C			–40°C to 85°C		–40°C to 125°C		UNIT	
FARAMETER	(INPUT)	(INPUT) (OUTPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>pd</sub>	А	Y			6.7 <sup>(1)</sup>	11.3 <sup>(1)</sup>	1	13.5	1	13.5		
t <sub>en</sub>	OE	Y	C <sub>L</sub> = 15 pF		8.5 <sup>(1)</sup>	16.6 <sup>(1)</sup>	1	19.5	1	19.5	ns	
t <sub>dis</sub>	OE	Y			8.4 <sup>(1)</sup>	13.1 <sup>(1)</sup>	1	15	1	15		
t <sub>pd</sub>	А	Y			8.7	15.9	1	18.5	1	18.5		
t <sub>en</sub>	OE	Y	0 50 55		10.5	20.7	1	24	1	24		
t <sub>dis</sub>	OE	Y	C <sub>L</sub> = 50 pF		12.3	17.9	1	20	1	20	ns	
t <sub>sk(o)</sub>						2		2		2		

(1) On products compliant to MIL-PRF-38535, this parameter is not production tested.

### 7.7 Switching Characteristics, $V_{CC} = 3.3 V \pm 0.3 V$

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

DADAMETED	FROM	то	LOAD CAPACITANCE	T <sub>A</sub> = 25°C	T <sub>A</sub> = 25°C		–40°C to 85°C		125°C	
PARAMETER	(INPUT)	) (OUTPUT)		MIN TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>pd</sub>	А	Y		4.8 <sup>(1)</sup>	7 <sup>(1)</sup>	1	8.5	1	8.5	
t <sub>en</sub>	OE	Y	C <sub>L</sub> = 15 pF	6.1 <sup>(1)</sup>	10.5 <sup>(1)</sup>	1	12.5	1	12.5	ns
t <sub>dis</sub>	ŌE	Y		5.8 <sup>(1)</sup>	11 <sup>(1)</sup>	1	12	1	12	
t <sub>pd</sub>	А	Y		6.1	10.5	1	12	1	12	
t <sub>en</sub>	OE	Y		7.4	14	1	16	1	16	
t <sub>dis</sub>	OE	Y	C <sub>L</sub> = 50 pF	8.8	15.4	1	17.5	1	17.5	ns
t <sub>sk(o)</sub>					1.5		1.5		1.5	

(1) On products compliant to MIL-PRF-38535, this parameter is not production tested.



### 7.8 Switching Characteristics, $V_{cc} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

	•	Ŭ				, ,	• ·	1000 10	40500		
PARAMETER	FROM (INPUT)	FROM	то	LOAD	T <sub>A</sub> = 25°	L	–40°C to	85.0	–40°C to	125 0	UNIT
		(OUTPUT)	CAPACITANCE	MIN TYP	MAX	MIN	MAX	MIN	MAX	ONIT	
t <sub>pd</sub>	А	Y		3.5 <sup>(1)</sup>	5 <sup>(1)</sup>	1	6	1	6		
t <sub>en</sub>	OE	Y	C <sub>L</sub> = 15 pF	4.3 <sup>(1)</sup>	7.2 <sup>(1)</sup>	1	8.5	1	8.5	ns	
t <sub>dis</sub>	OE	Y		3.9 <sup>(1)</sup>	7.5 <sup>(1)</sup>	1	8	1	8		
t <sub>pd</sub>	А	Y		4.3	7	1	8	1	8		
t <sub>en</sub>	OE	Y	0 50 - 5	5.3	9.2	1	10.5	1	10.5		
t <sub>dis</sub>	OE	Y	C <sub>L</sub> = 50 pF	5.6	8.8	1	10	1	10	ns	
t <sub>sk(o)</sub>					1		1		1		

(1) On products compliant to MIL-PRF-38535, this parameter is not production tested.

### 7.9 Noise Characteristics<sup>(1)</sup>

 $V_{CC}$  = 3.3 V,  $C_L$  = 50 pF,  $T_A$  = 25°C

	PARAMETER	SN	SN74LV541A						
	PARAMETER	MIN	TYP	MAX	UNIT				
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.5	0.8	V				
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>		-0.4	-0.8	V				
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>		2.9		V				
V <sub>IH(D)</sub>	High-level dynamic input voltage	2.31			V				
V <sub>IL(D)</sub>	Low-level dynamic input voltage			0.99	V				

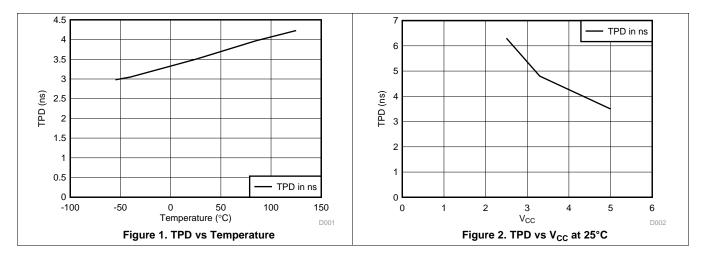
(1) Characteristics are for surface-mount packages only.

### 7.10 Operating Characteristics

 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST C	ONDITIONS	Vcc	TYP	UNIT
C <sub>pd</sub> Power dissipation capacitance	O dan ta anal la d		f 10 MU	3.3 V	16.3	E
	Power dissipation capacitance	Outputs enabled	$C_{L} = 50 \text{ pF},$	f = 10 MHz	5 V	17.8

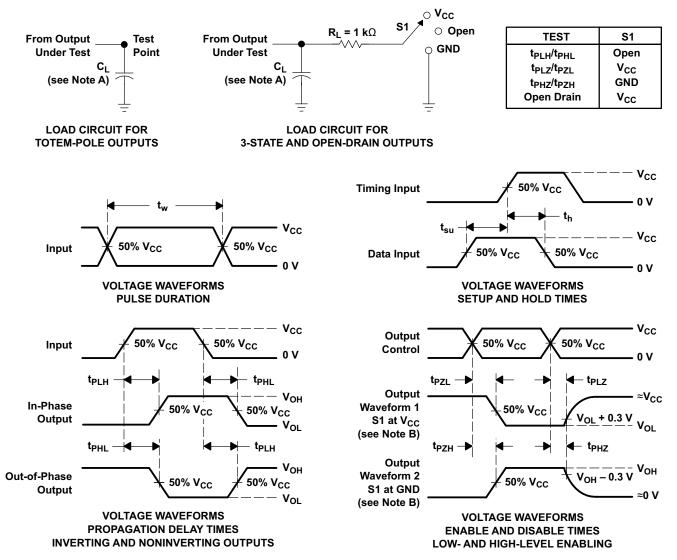
### 7.11 Typical Characteristics



SN74LV541A SCLS410J – APRIL 1998–REVISED DECEMBER 2014

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#### 8 Parameter Measurement Information



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PHL}$  and  $t_{PLH}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

#### Figure 3. Load Circuit and Voltage Waveforms



### 9 Detailed Description

#### 9.1 Overview

The SN74LV541A device is an octal buffers/driver designed for 2-V to 5.5-V V<sub>CC</sub> operation.

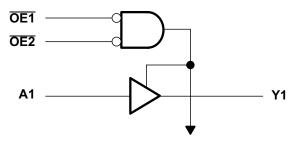
The SN74LV541A device is ideal for driving bus lines or buffer memory address registers. It features inputs and outputs on opposite sides of the package to facilitate printed circuit board layout.

The 3-state control gate is a two-input AND gate with active-low inputs so that if either output-enable ( $\overline{OE1}$  or  $\overline{OE2}$ ) input is high, all corresponding outputs are in the high-impedance state. The outputs provide non-inverted data when they are not in the high-impedance state.

To ensure the high-impedance state during power up or power down, both  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pull-up resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74LV541A device are fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

#### 9.2 Functional Block Diagram



To Seven Other Channels Figure 4. Logic Diagram (Positive Logic)

#### 9.3 Feature Description

- · Wide operating voltage range
  - Operates from 2 V to 5.5 V
- Allows down-voltage translation
- Inputs accept voltages to 5.5 V
- I<sub>off</sub> feature
  - Allows voltages on the inputs when  $V_{CC}$  is 0 V

#### 9.4 Device Functional Modes

# Table 2. Function Table(Each Buffer or Driver)

	OUTPUT		
OE1	OE2	Α	Y
L	L	L	L
L	L	Н	Н
Н	Х	Х	Z
Х	Н	Х	Z

SN74LV541A

SCLS410J-APRIL 1998-REVISED DECEMBER 2014

### 10 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### **10.1** Application Information

SN74LV541A is a low-drive CMOS device that can be used for a multitude of bus interface type applications where the data needs to be retained or latched. It can produce 16 mA of drive current at 5 V, making it Ideal for driving multiple outputs and good for low noise applications. The inputs are 5.5-V tolerant allowing it to translate down to  $V_{CC}$ .

#### **10.2 Typical Application**

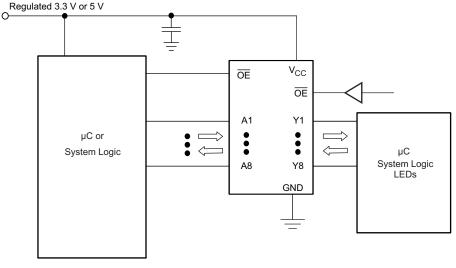


Figure 5. Typical Application Schematic

#### 10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

### 10.2.2 Detailed Design Procedure

1. Recommended Input Conditions

- For rise time and fall time specifications, see  $\Delta t/\Delta V$  in the *Recommended Operating Conditions* table.
- For specified High and low levels, see  $V_{IH}$  and  $V_{IL}$  in the *Recommended Operating Conditions* table.

Product Folder Links: SN74LV541A

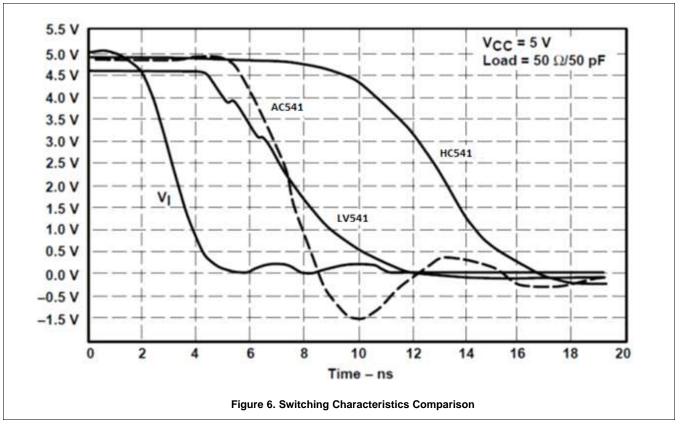
- Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid  $V_{CC}$ .
- 2. Recommend Output Conditions
  - Load currents should not exceed 35 mA per output and 70 mA total for the part.
  - Outputs should not be pulled above V<sub>CC</sub>.

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### **Typical Application (continued)**

### 10.2.3 Application Curves



### **11** Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each V<sub>CC</sub> pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu$ F is recommended. If there are multiple V<sub>CC</sub> pins, 0.01  $\mu$ F or 0.022  $\mu$ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu$ F and 1  $\mu$ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

TEXAS INSTRUMENTS

### 12 Layout

#### 12.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 7 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the I/Os so they also cannot float when disabled.

#### 12.2 Layout Example

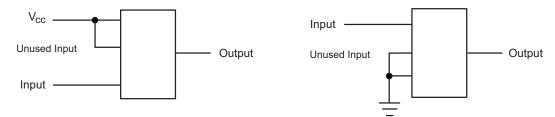


Figure 7. Layout Diagram

### **13 Device and Documentation Support**

#### 13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

#### Table 3. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN74LV541A	Click here	Click here	Click here	Click here	Click here	

#### 13.2 Trademarks

All trademarks are the property of their respective owners.

#### 13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

### 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)	(-)			
SN74LV541ADBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541ADBRE4	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541ADBRG4	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541ADW	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541ADWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541ANSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	74LV541A	Samples
SN74LV541APW	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541APWG4	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541APWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541APWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541APWT	ACTIVE	TSSOP	PW	20	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV541A	Samples
SN74LV541ARGYR	ACTIVE	VQFN	RGY	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LV541A	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.



## PACKAGE OPTION ADDENDUM

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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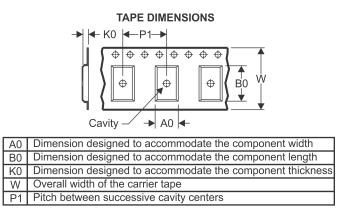
## PACKAGE MATERIALS INFORMATION

Texas Instruments

www.ti.com

### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

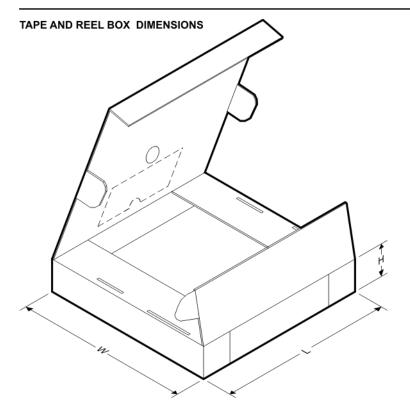


*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV541ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74LV541ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74LV541ANSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74LV541APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LV541APWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74LV541APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LV541ARGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1



## PACKAGE MATERIALS INFORMATION

12-Mar-2022



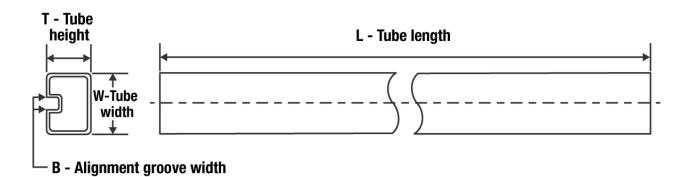
\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV541ADBR	SSOP	DB	20	2000	853.0	449.0	35.0
SN74LV541ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LV541ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LV541APWR	TSSOP	PW	20	2000	364.0	364.0	27.0
SN74LV541APWRG4	TSSOP	PW	20	2000	853.0	449.0	35.0
SN74LV541APWT	TSSOP	PW	20	250	853.0	449.0	35.0
SN74LV541ARGYR	VQFN	RGY	20	3000	853.0	449.0	35.0



12-Mar-2022

### TUBE



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN74LV541ADW	DW	SOIC	20	25	507	12.83	5080	6.6
SN74LV541APW	PW	TSSOP	20	70	530	10.2	3600	3.5
SN74LV541APWG4	PW	TSSOP	20	70	530	10.2	3600	3.5

# **DB0020A**



## **PACKAGE OUTLINE**

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



# DB0020A

# **EXAMPLE BOARD LAYOUT**

## SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DB0020A

# **EXAMPLE STENCIL DESIGN**

## SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



### MECHANICAL DATA

### PLASTIC SMALL-OUTLINE PACKAGE

#### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## **GENERIC PACKAGE VIEW**

## VQFN - 1 mm max height

PLASTIC QUAD FGLATPACK - NO LEAD

3.5 x 4.5, 0.5 mm pitch

**RGY 20** 

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





4225264/A

# **RGY0020A**



## **PACKAGE OUTLINE**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



# **RGY0020A**

# **EXAMPLE BOARD LAYOUT**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



# **RGY0020A**

# **EXAMPLE STENCIL DESIGN**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



# **DW0020A**



## **PACKAGE OUTLINE**

## SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



## DW0020A

# **EXAMPLE BOARD LAYOUT**

## SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## DW0020A

# **EXAMPLE STENCIL DESIGN**

## SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# **PW0020A**



## **PACKAGE OUTLINE**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



## PW0020A

# **EXAMPLE BOARD LAYOUT**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## PW0020A

# **EXAMPLE STENCIL DESIGN**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
  C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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